

Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			ATTY. KET NO. IS15-00		SERIAL NO. 10/525,881	
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)					APPLICANT Tatsuya Matsui, et al.			
					FILING DATE February 24, 2005		GROUP Unknown	
U.S. PATENT DOCUMENTS								
Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
	AA							
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FOREIGN PATENT DOCUMENTS								
		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
/AWS/	AM	EP 399962 A1	11/28/90	EPO				
/AWS/	AN	JP 2002-166375	6/11/02	Japan				X
/AWS/	AO	JP 5-317145	12/3/93	Japan				X
/AWS/	AP	JP 11-179063	7/06/99	Japan				X
/AWS/	AQ	JP 2002-63505	2/28/02	Japan				X
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)								
	AR							
	AS							
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EV550719408

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	AL							
FOREIGN PATENT DOCUMENTS								
		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
/AWS/	AM	JP 5-269260	10/19/93	Japan				X
/AWS/	AN	JP 7-104692	4/21/95	Japan				X
/AWS/	AO	JP 53-91499	7/26/78	Japan				X
	AP							
	AQ							
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)								
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